



NASA Electronic Parts and Packaging Program (NEPP)



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Title: Reworkable Underfill Characterization
 New Proposal Continuing NEPP Work

Total \$ Requirement for FY 01: \$ 325

Technology Type: Newly Available (COTS) Emerging/Advanced

Project Area: Parts Packaging Radiation

Proposing Center: Jet Propulsion Laboratory

Participating Centers: **21%** GSFC **0%** GRC **21%** LaRC
55% JPL **3%** MSFC **0%** JSC

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Objectives:

- Demonstrate a reworkable organic underfill using a high I/O package and die with low rigidity meeting the harsh dynamic requirements for space. This task will define, characterize, and validate techniques for rework and repair of devices following an underfill process. Evaluation will include development of validation, assessment and test methods/tools, advanced adhesion technology evaluation, process characterization and interconnect reliability guidelines as they relate reworkable underfill materials systems. The current standard non-reworkable materials will be used as control.
- Disseminate guidelines for quality assurance and reliability to NASA projects for hardware and processes as well as industry.

NASA Customers: NASA-wide advocacy including X-2000, SIM, HEDS, Mars Exploration Programs at JPL, PICASSO, GAMS, STS, at LARC, Next Generation Telescope at GSFC, JPL-led consortia (see below), Virginia power through LARC, Ames/MSFC/JSC through COTS support.

Deliverables:

- Test matrix design of experiments for different underfill materials
- Inspection criteria and quantifiable assembly data for acceptable adhesion and flow
- Quality Assurance guidelines
- Training course and technical papers in NASA EEE Links, industry-wide conferences and trade magazines

Schedule:



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Description and Technical Approach

Association Connecting Electronics Industries (IPC) : Collaborate to release NASA/IPC guidelines for this technology

This task will characteristics key properties of underfill including bonding by mechanical and thermal test methods. Dies will be assembled on board with conventional and reworkable underfills and will be subjected to environmental testing to establish damage progress and failure. In addition based on results of no-destructive evaluation (NDE) and destructive physical analyses, defect correlation and to reliability will be established for reworkable underfill applications. These results will be used to bound critical parameters and to provide standards/inspection criteria guidelines for the optimum underfill condition for best reliability performance. Will provide guidelines document and will use knowledge and experience gained to effectively support the projects in these areas